

Supplementary information

Elucidating interfacial parameters of platinum–palladium bulk alloy single crystals

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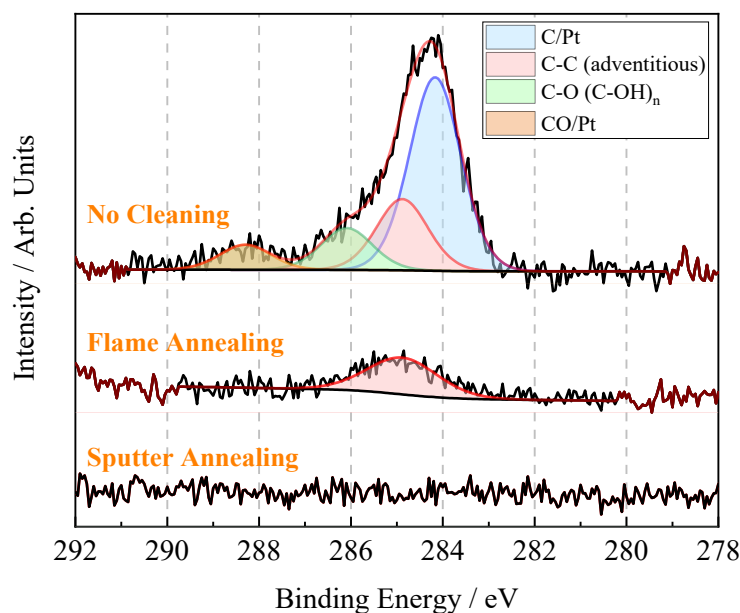


Figure S1. XPS C1s spectra of an as-prepared, flame-annealed, and sputter-annealed Pt(100) single crystal.

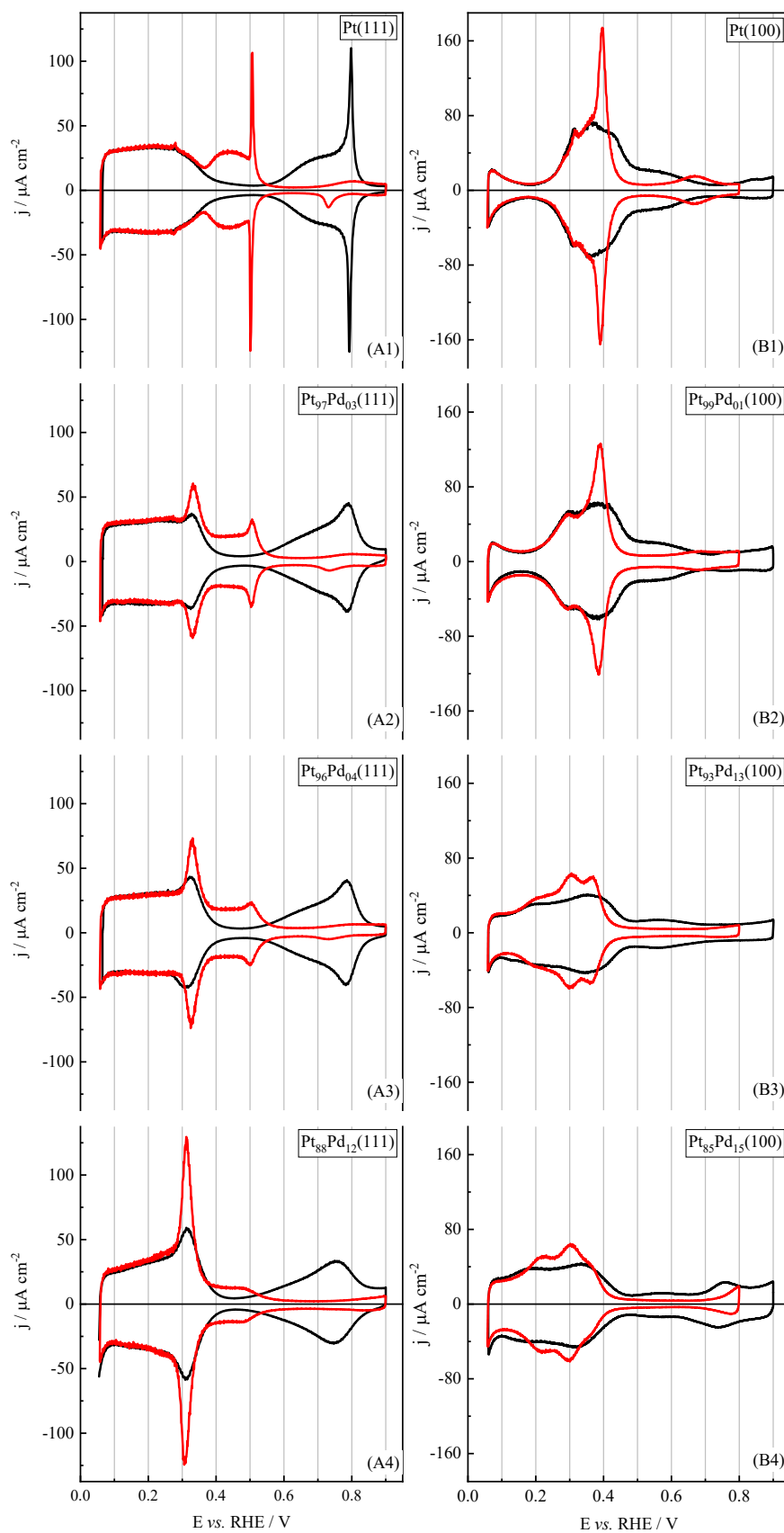


Figure S2. Comparison of the voltammetric profiles of the (A1-A4) $\text{Pt}_{100-x}\text{Pd}_x(111)$ and (B1-B4) $\text{Pt}_{100-x}\text{Pd}_x(100)$ surfaces, recorded at $0.05 \text{ V}\cdot\text{s}^{-1}$, in (black line) $0.1 \text{ mol}\cdot\text{L}^{-1} \text{ HClO}_4$ and (red line) $0.1 \text{ mol}\cdot\text{L}^{-1} \text{ H}_2\text{SO}_4$.

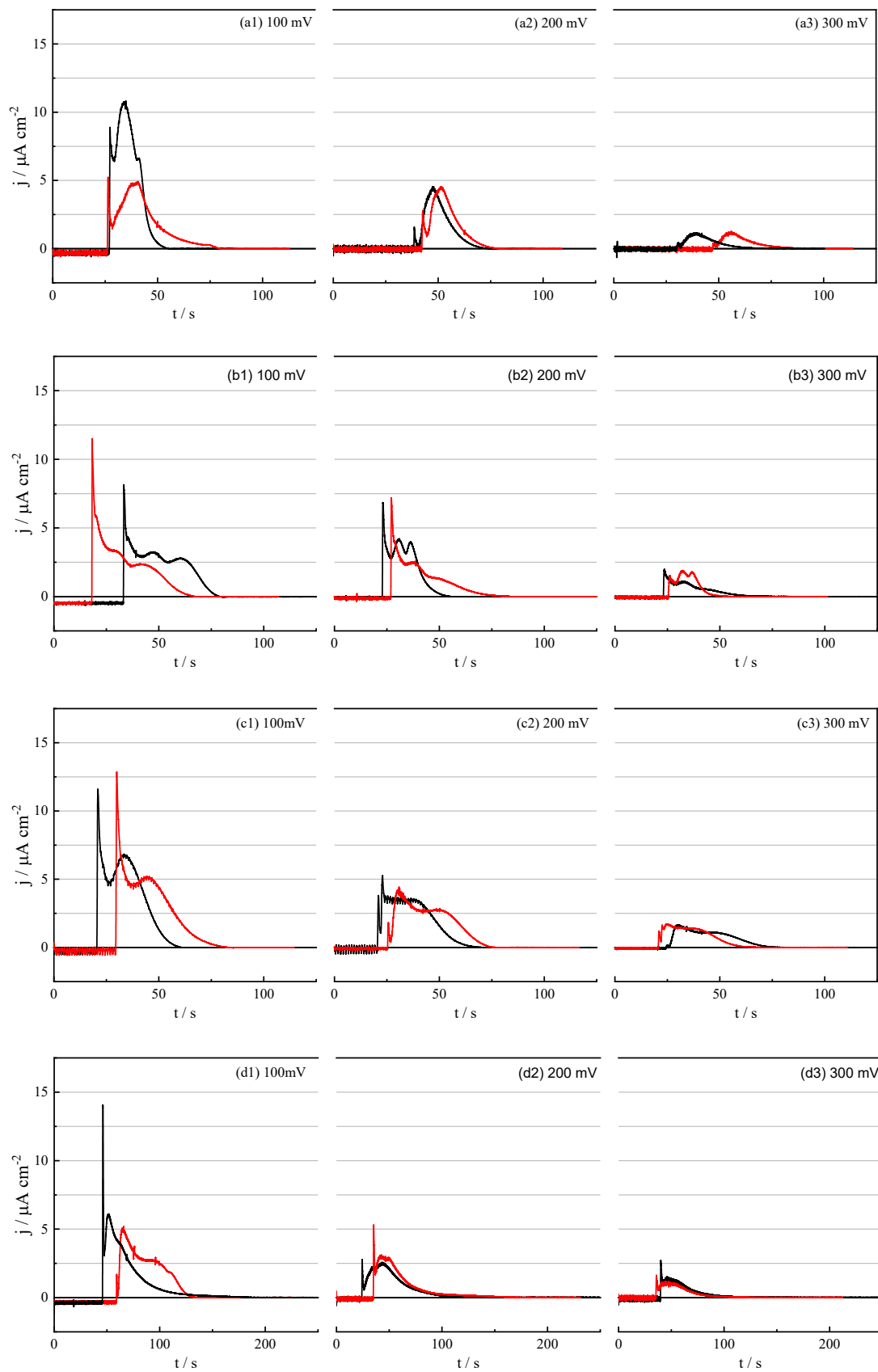
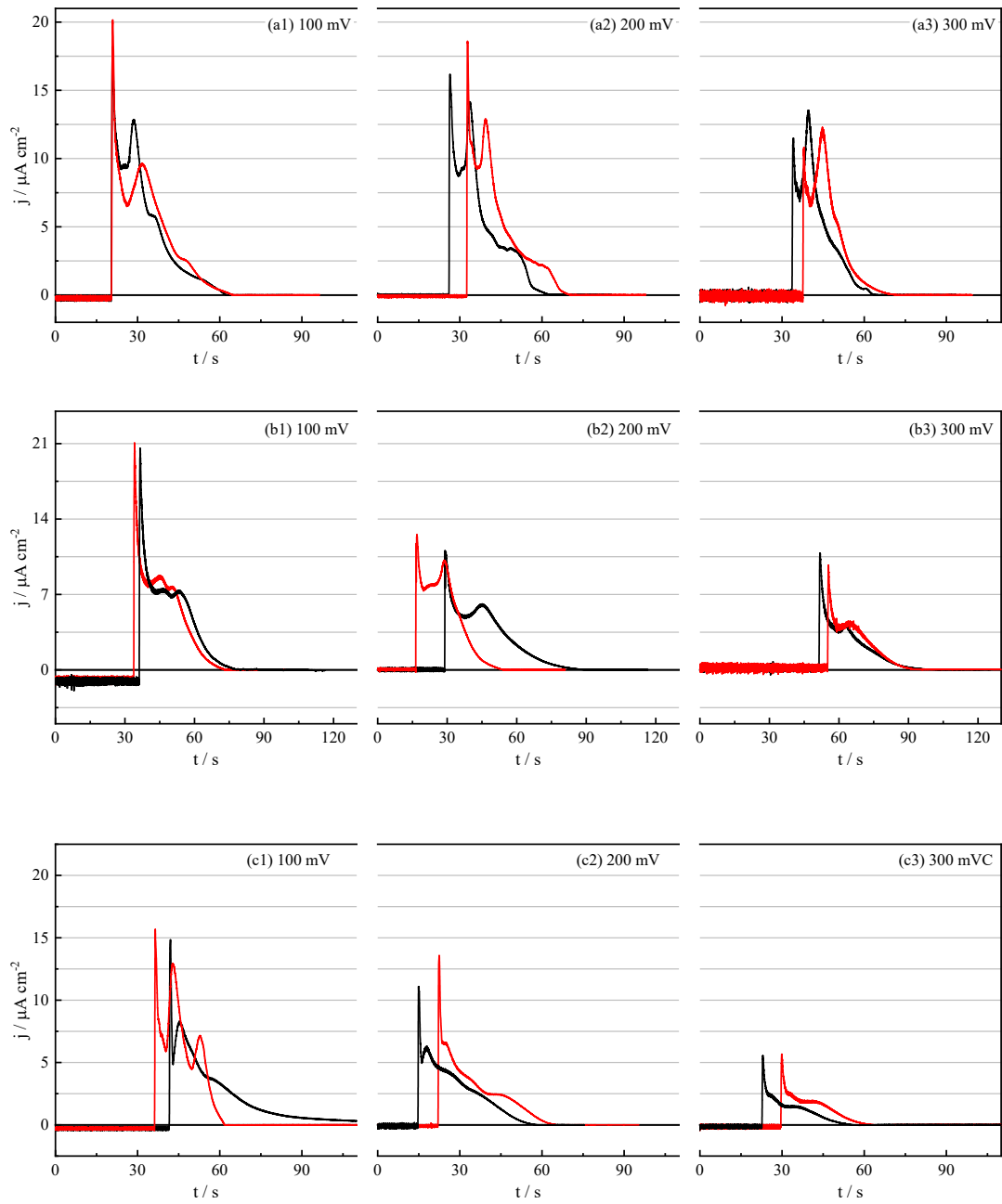


Figure S3. Typical transient of current for CO displacement at (a1-d1) 100 mV, (a2-d2) 200 mV, and (a3-d3) 300 mV for (a) Pt(111), (b) Pt₉₇Pd₀₃(111), (c) Pt₉₆Pd₀₄(111), and (d) Pt₈₈Pd₁₂(111) surface in 0.1 mol L⁻¹ HClO₄. The black and red curves are the results of experiments repeated on different days.

Table S1. Charge density measured during CO displacement experiments at 0.10, 0.20, or 0.30 V on Pt(111) or PtPd(111) family. Numerical value of the charge density with the error is the mean value and the standard deviation, respectively, determined by replicating the experiments 3 or more times.

E vs. RHE / V	Charge / $\mu\text{C cm}^{-2}$			
	Pt(111)	Pt ₉₇ Pd ₀₃ (111)	Pt ₉₆ Pd ₀₄ (111)	Pt ₈₈ Pd ₁₂ (111)
0.100	141.5 ± 1.5	137.6 ± 0.4	155.5 ± 0.5	159 ± 3
0.200	62 ± 4	85.5 ± 0.4	102.2 ± 0.9	92 ± 3
0.300	18.0 ± 0.3	29.0 ± 0.7	40.0 ± 0.6	35 ± 3



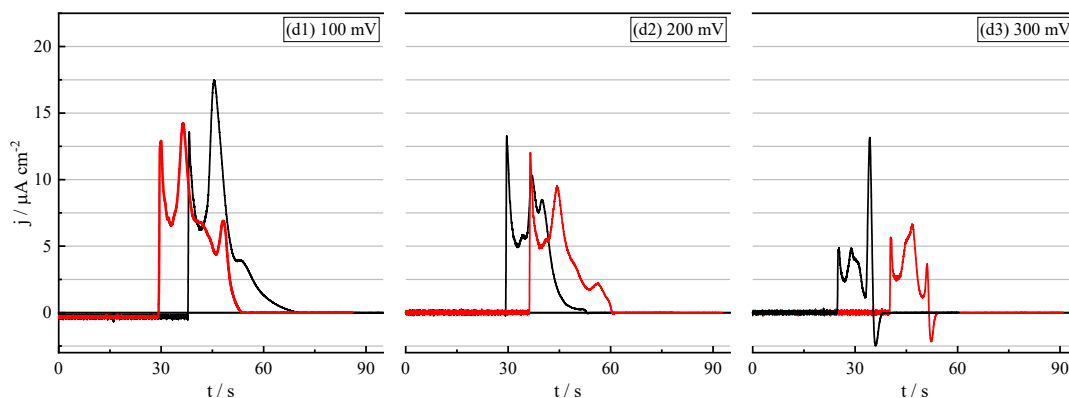


Figure S4. Transient of current for CO displacement at (a1-d1) 100, (a2-d2) 200, and (a3-d3) 300 mV for (a) Pt(100), (b) Pt₉₉Pd₀₁(100), (c) Pt₉₃Pd₀₇(100), and (d) Pt₈₅Pd₁₅(100) surface in 0.1 mol L⁻¹ HClO₄. The black and red curves are the results of experiments repeated on different days.

Table S2. Charge density measured during the displacement of CO experiments at 0.10, 0.20, or 0.30 V on Pt(100) or PtPd(100) family.

E vs. RHE / V	Charge / $\mu\text{C cm}^{-2}$			
	Pt(100)	Pt ₉₉ Pd ₀₁ (100)	Pt ₉₃ Pd ₀₇ (100)	Pt ₈₅ Pd ₁₅ (100)
0.100	202 ± 3	209 ± 3	171 ± 6	176 ± 6
0.200	186 ± 1	177 ± 2	123 ± 4	119 ± 3
0.300	135 ± 4	92 ± 6	47 ± 5	39.0 ± 0.5

Table S3. Supplemental information about CO oxidation on Pt(111) and PtPd(111) family.

SURFACE	Integrated Charge / $\mu\text{C cm}^{-2}$	Total charge at 0.90 V / $\mu\text{C cm}^{-2}$	Corrected Charge / $\mu\text{C cm}^{-2}$	E _{peak} / V
Pt(111)	487 ± 6	166	321 ± 5	0.755 ± 0.005
Pt ₉₇ Pd ₀₃ (111)	485 ± 10	153	332 ± 10	0.761 ± 0.009
Pt ₉₆ Pd ₀₄ (111)	501 ± 5	159	342 ± 5	0.772 ± 0.005
Pt ₈₈ Pd ₁₂ (111)	486 ± 5	166	320 ± 5	0.764 ± 0.004

Table S4. Supplemental information about CO oxidation on Pt(100) and PtPd(100) family.

SURFACE	Integrated Charge	Total charge at 0.85 V / $\mu\text{C cm}^{-2}$	Corrected Charge	E _{peak} / V
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	$/\mu\text{C cm}^{-2}$		$/\mu\text{C cm}^{-2}$	
Pt(100)	490 ± 5	160	330 ± 5	0.738 ± 0.005
Pt ₉₉ Pd ₀₁ (100)	512 ± 8	166	346 ± 8	0.729 ± 0.007
Pt ₉₃ Pd ₀₇ (100)	455 ± 4	137	318 ± 4	0.722 ± 0.005
Pt ₈₅ Pd ₁₅ (100)	511 ± 11	155	356 ± 11	0.7904 ± 0008